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Yetai Fei
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Contents

xvii	<i>Conference Committee</i>
xxi	<i>Introduction</i>

SIXTH INTERNATIONAL SYMPOSIUM ON PRECISION MECHANICAL MEASUREMENTS

8916 02	Nondestructive optical characterization of MEMS [8916-236] R. J. Pryputniewicz, Worcester Polytechnic Institute (United States)
8916 03	Traceability of measurements at the nanoscale [8916-222] H. Bosse, Physikalisch-Technische Bundesanstalt (Germany)
8916 04	Adaptive fractional differential method based on CSGV to extract image texture feature [8916-166] A. Song, W. Wang, Southeast Univ. (China)
8916 05	Development of transmission error tester for face gears [8916-233] Z. Shi, X. Lu, C. Chen, J. Lin, Beijing Univ. of Technology (China)
8916 06	Computational metrology for nanomanufacturing [8916-27] S. Liu, Huazhong Univ. of Science and Technology (China)
8916 07	An experiment of femtosecond laser absolute distance measurement by spectrally resolved interferometry [8916-42] W. Zhou, Academy of Opto-Electronics (China); Y. Li, Academy of Opto-Electronics (China) and Huazhong Univ. of Science and Technology (China); R. Ji, Academy of Opto-Electronics (China); Y. Xu, Academy of Opto-Electronics (China) and Huazhong Univ. of Science and Technology (China); D. Liu, Huazhong Univ. of Science and Technology (China)
8916 09	Dimensional measurement of micrometer-scale structures with a nanopipette ball probe by using shear-force detection [8916-215] S. Ito, I. Kodama, W. Gao, Tohoku Univ. (Japan)
8916 0A	Development of a miniature multi-degree-of-freedom measurement system for ultra-precision stages [8916-14] H.-Y. Wang, B.-H. Liao, M.-J. Chou, Y.-Y. Tseng, K.-C. Fan, National Taiwan Univ. (Taiwan, China)
8916 0B	Using acceleration measurements and neuro-fuzzy systems for monitoring and diagnosis of bearings [8916-181] T.-I. Liu, California State Univ. Sacramento (United States) and National Taipei Univ. of Technology (Taiwan, China); J. Lee, P. Singh, California State Univ. Sacramento (United States); G. Liu, Mori Seiki Manufacturing USA, Inc. (United States)

- 8916 0C **Nanometrology interferometric coordinates measurement system for local probe microscopy** [8916-10]
J. Hrabina, J. Lazar, Institute of Scientific Instruments (Czech Republic); P. Klapetek, Czech Metrology Institute (Czech Republic); O. Cip, M. Cizek, M. Sery, Institute of Scientific Instruments (Czech Republic)
- 8916 0D **Review and comparison of temporal- and spatial-phase shift speckle pattern interferometry for 3D deformation measurement** [8916-235]
X. Xie, L. Yang, X. Chen, N. Xu, Oakland Univ. (United States); Y. Wang, Hefei Univ. of Technology (China)
- 8916 0E **Analysis and experimental study of the spherical joint clearance** [8916-79]
P. Zhao, P. Hu, X. Bao, S. Li, Hefei Univ. of Technology (China)
- 8916 0F **Characteristics of the higher-order resonant cantilever in dynamic atomic force microscopy** [8916-211]
Y. Zhao, Hefei Univ. of Technology (China) and Anhui Jianzhu Univ. (China); Q. Huang, K. Shi, H. You, H. Xie, Hefei Univ. of Technology (China)
- 8916 0G **Key errors analysis and simulation of a 3-PUU parallel CMM** [8916-71]
S. Li, S. Li, P. Zhao, P. Hu, Hefei Univ. of Technology (China)
- 8916 0H **Measurement uncertainty analysis on laser tracker combined with articulated CMM** [8916-234]
H. Zhao, L. Yu, Y. Du, H. Zhang, Hefei Univ. of Technology (China)
- 8916 0I **Variable stiffness and damping semi-active vibration control technology based on magnetorheological fluids** [8916-202]
S. Zhao, H. Deng, J. Zhang, Hefei Univ. of Technology (China); S. Sun, Hefei Univ. of Technology (China) and Univ. of Wollongong (Australia); L. Wang, Hefei Univ. of Technology (China)
- 8916 0J **Three-dimensional reconstruction coordinate error induced by asynchronous cameras for moving objects** [8916-187]
Y. Wang, J. Zhang, H. Deng, R. Fan, Hefei Univ. of Technology (China)
- 8916 0K **Surface roughness measurement based on digital laser speckle pattern by Markov Random Fields Model in wavelet domain** [8916-157]
L. Yang, R. Lu, L. Lei, Z. Liu, Hefei Univ. of Technology (China); Y. Shi, Huainan Union Univ. (China); L. Lei, Z. Liu, Hefei Univ. of Technology (China)
- 8916 0L **The optimal design for measurement systems based on uniform accuracy life** [8916-146]
Z.-Y. Cheng, X.-H. Chen, R. Li, Hefei Univ. of Technology (China); M. Jiang, Zhejiang Normal Univ. (China); Y. Fei, Hefei Univ. of Technology (China)
- 8916 0M **Evaluation of measurement uncertainty based on Bayesian information fusion** [8916-77]
S. Wang, X. Chen, Q. Yang, Hefei Univ. of Technology (China)
- 8916 0N **A robust sinusoidal signal processing method for interferometers** [8916-61]
X. Wu, H. Zhang, Hefei Univ. of Technology (China); Y.-Y. Tseng, National Taiwan Univ. (Taiwan, China); K.-C. Fan, Hefei Univ. of Technology (China) and National Taiwan Univ. (Taiwan, China)

- 8916 0O **DSPI system based on spatial carrier phase shifting technique** [8916-231]
Y. Wang, J. Li, J. Sun, Hefei Univ. of Technology (China); L. Yang, Hefei Univ. of Technology (China) and Oakland Univ. (United States)
- 8916 0P **Elastic mechanism design of a CMM contact probe** [8916-121]
R.-J. Li, Hefei Univ. of Technology (China) and Anhui Electrical Engineering Professional Technique College (China); K.-C. Fan, Hefei Univ. of Technology (China) and National Taiwan Univ. (Taiwan, China); H. Zhou, N. Wang, Q. Huang, Hefei Univ. of Technology (China)
- 8916 0Q **Measurement of transient surface temperatures during rubbing using infrared thermography** [8916-172]
T. You, J. Yu, X. Yu, Hefei Univ. of Technology (China)
- 8916 0R **A designed circuit for sintering optical fiber probe** [8916-200]
Z. Ai, S. Dong, Q. Yang, N. Lin, Y. Xu, Hefei Univ. of Technology (China)
- 8916 0S **Optimization of BRDF measurement method using Spectralon white reflectance standard** [8916-58]
H.-R. Tao, X.-H. Qu, F.-M. Zhang, Y.-Q. Zhu, Tianjin Univ. (China)
- 8916 0T **An indirect accuracy calibration and uncertainty evaluation method for large scale inner dimensional measurement system** [8916-12]
B.-L. Liu, X.-H. Qu, Tianjin Univ. (China)
- 8916 0U **The combined measurement and compensation technology for robot motion error** [8916-49]
R. Li, X. Qu, Y. Deng, B. Liu, Tianjin Univ. (China)
- 8916 0V **Fiber optic interferometer fringe projector using sinusoidal phase-modulating** [8916-167]
C. Lv, F. Duan, F. Zhang, X. Duan, E. Bo, F. Feng, Tianjin Univ. (China)
- 8916 0W **Simulation and signal analysis of Akiyama probe applied to atomic force microscope** [8916-78]
L. Wang, Tianjin Univ. (China); M. Lu, National Institute of Metrology (China); T. Guo, Tianjin Univ. (China); S. Gao, H. Zhang, National Institute of Metrology (China)
- 8916 0X **Phase modulation dynamic AFM measurement system based on tuning fork probe** [8916-91]
T. Guo, W. Chen, Z. Wu, J. Chen, X. Fu, X. Hu, Tianjin Univ. (China)
- 8916 0Y **Design and finite element analysis of the vibration isolation system of STM** [8916-238]
Y. Liu, X. Fu, L. Xu, Y. Song, Tianjin Univ. (China)
- 8916 0Z **An effective signal separation and extraction method using multi-scale wavelet decomposition for phase-sensitive OTDR system** [8916-151]
H. Wu, X. Li, H. Li, Y. Wu, Y. Gong, Y. Rao, Univ. of Electronic Science and Technology (China)

- 8916 10 **Analysis of the forces in electrostatic force microscopy for profile measurement of micro-structured surface of dielectric** [8916-73]
G. He, Chongqing Univ. of Science and Technology (China) and Tohoku Univ. (Japan); Z. Jia, S. Ito, Y. Shimizu, W. Gao, Tohoku Univ. (Japan)
- 8916 11 **A kinematic parameter calibration method for articulated arm coordinate measuring machine** [8916-114]
S. Zhao, L. Zhu, Q. Chen, Z. Pan, Y. Guo, Beijing Information Science & Technology Univ. (China)
- 8916 12 **Technique of laser confocal and Raman spectroscopy for living cell analysis** [8916-13]
X. Meng, L. Zhu, Beijing Information Science & Technology Univ. (China)
- 8916 13 **All-fiber Q-switched ytterbium-doped fiber laser in MOPA configurations** [8916-147]
W. He, Hefei Univ. of Technology (China); L. Zhu, Hefei Univ. of Technology (China) and Beijing Information Science & Technology Univ. (China); Y. Zhang, M. Dong, Beijing Information Science & Technology Univ. (China); X. Chen, Hefei Univ. of Technology (China)
- 8916 14 **Harmonic distortion analysis of a Mach-Zehnder intensity modulator** [8916-208]
X. Zhang, Beijing Information Science & Technology Univ. (China); S. Hu, Beijing Univ. of Aeronautics and Astronautics (China); Y. Jia, Z. Zhou, L. Liao, Beijing Information Science & Technology Univ. (China)
- 8916 15 **Design of high current voltage conversion circuit based on LT3743** [8916-203]
G. Cai, X. Lou, Y. Zhang, Y. Na, Q. Liu, Beijing Information Science & Technology Univ. (China)
- 8916 16 **Structure parameters optimization and system simulation of a double-triangulation probe** [8916-132]
D. Cheng, X. Lou, Q. Liu, M. Dong, Beijing Information Science & Technology Univ. (China)
- 8916 17 **Dynamic measurement of deformation using Fourier transform digital holographic interferometry** [8916-188]
X. Gao, S. Wu, L. Yang, Beijing Information Science & Technology Univ. (China)
- 8916 18 **Research on amplification and peak-holding circuits of nanosecond light pulse** [8916-193]
H. Liu, Y. Zhang, Y. Na, Beijing Information Science & Technology Univ. (China)
- 8916 19 **An improved centroid location algorithm for Infrared LED feature points** [8916-137]
S. Wang, B. Yan, M. Dong, J. Wang, P. Sun, Beijing Information Science & Technology Univ. (China)
- 8916 1A **Simulation research of acousto optic modulator drive based on Multisim** [8916-160]
S. Wang, Y. Guo, L. Zhu, Y. Na, Y. Zhang, Q. Liu, Beijing Information Science & Technology Univ. (China)
- 8916 1B **An accuracy evaluating method for image point location based on linear fitting** [8916-124]
L. Xu, M. Dong, J. Wang, P. Sun, Beijing Information Science & Technology Univ. (China)

- 8916 1C **Quasi-distributed temperature sensor system based on various-packaged FBG** [8916-199]
Y. Zhang, Q. Liu, Beijing Information Science & Technology Univ. (China); W. He, Hefei Univ. of Technology (China); L. Zhu, Beijing Information Science & Technology Univ. (China)
- 8916 1D **Optical tweezers based on cylindrical vector beams** [8916-169]
Y. Xu, Z. Zhou, X. Zhang, Z. Zhao, L. Zhu, Beijing Information Science & Technology Univ. (China)
- 8916 1E **Measuring the lens focal length by laser confocal technique** [8916-128]
H. Wu, J. Yang, L. Qiu, W. Zhao, Beijing Institute of Technology (China)
- 8916 1F **A method for extracting feature points of micro-calibration sample** [8916-197]
Y. Niu, J. Pan, X. Wang, Beijing Information Science & Technology Univ. (China)
- 8916 1G **A variable weighted centroid method for retro reflective target locating** [8916-103]
W. Zhuang, M. Dong, P. Sun, J. Wang, Beijing Information Science & Technology Univ. (China)
- 8916 1H **Digital approach to stabilizing optical frequency combs and beat notes of CW lasers** [8916-83]
M. Čížek, O. Číp, R. Šmíd, J. Hrabina, B. Mikel, J. Lazar, Institute of Scientific Instruments (Czech Republic)
- 8916 1I **Calibration of elongation of fiber Bragg gratings by laser interferometer** [8916-82]
B. Mikel, M. Cizek, Institute of Scientific Instruments (Czech Republic); M. Holik, Brno Univ. of Technology (Czech Republic); O. Cip, Institute of Scientific Instruments (Czech Republic)
- 8916 1J **Interferometry with suppression of fast fluctuations of the refractive index of air for nanometrology** [8916-28]
J. Lazar, M. Hola, J. Hrabina, Z. Buchta, O. Cip, Institute of Scientific Instruments (Czech Republic)
- 8916 1K **The investigation of electrolytic surface roughening for PCB copper foil** [8916-239]
S.-J. Lee, C.-K. Liu, Yuan Ze Univ. (Taiwan, China)
- 8916 1L **A three-degree-of-freedom hybrid vibration isolation system using adaptive proportional control supported by passive weight support mechanism** [8916-230]
Y.-H. Liu, W.-H. Wu, C.-L. Chu, Southern Taiwan Univ. of Science and Technology (Taiwan, China)
- 8916 1M **Development of a micro-CMM with scanning touch probe and high-precision coplanar platform** [8916-195]
C.-L. Chu, C.-T. Lu, H.-L. Chen, J.-S. Ke, C.-M. Chang, Southern Taiwan Univ. of Science and Technology (Taiwan, China)
- 8916 1N **The performance of an inspection system for indium tin oxide circuits by using a PDLC/ITO film** [8916-54]
C.-H. Chan, National Tsing Hua Univ. (Taiwan, China); Y.-T. Zou, C.-T. Chen, T.-K. Liu, C.-H. Chen, H.-W. Wang, Industrial Technology Research Institute (Taiwan, China); S.-C. Lin, National Tsing Hua Univ. (Taiwan, China)

- 8916 1O **Optimizing the structure of a four-axis polarized scattering instrument using a double-loop approach** [8916-50]
C.-J. Shih, Tamkang Univ. (Taiwan, China); T.-L. Teng, Hsiuping Univ. of Science and Technology (Taiwan, China); Y.-A. Huang, Tamkang Univ. (Taiwan, China)
- 8916 1P **Optical magnetic field sensor improved by NdFeB ferromagnetic film** [8916-62]
T. G. Nguyen, X. Jiao, W. Lei, Y. Ma, L. Ma, Univ. of Shanghai for Science and Technology (China); B. Qian, Suzhou Institute of Nano-tech and Nano-bionics (China)
- 8916 1Q **Structure design and characteristic analysis of micro-nano probe based on six dimensional micro-force measuring principle** [8916-72]
H. Yang, C. Cai, C. Fang, T. Wu, Anhui Univ. of Technology (China)
- 8916 1R **Research and analysis of AC sampling standard value converting circuits** [8916-127]
L. Mu, Z. Li, Z. Chen, Anhui Univ. of Science and Technology (China)
- 8916 1S **Research on the working characteristic of Hall current sensor and the "modeling-deviation compensation" algorithm** [8916-206]
L. Mu, Z. Chen, Z. Li, Anhui Univ. of Science and Technology (China)
- 8916 1T **Multimodal image registration based on SURF and KD tree** [8916-177]
Y. Yin, Z. Gu, C. Du, Anhui Univ. of Chinese Medicine (China)
- 8916 1U **Study on real-time elevator brake failure predictive system** [8916-56]
J. Guo, J. Fan, Beijing Univ. of Technology (China)
- 8916 1V **Data repair method in incomplete free-surface measurement** [8916-31]
Z. Wang, Q. Li, H. Yan, Q. Wang, BeiHang Univ. (China)
- 8916 1W **Radial pressure sensor of sucker rod based on LabVIEW** [8916-33]
Z. Wang, H. Yan, Q. Li, BeiHang Univ. (China)
- 8916 1X **FPGA-based signal processing method of automatic interference comparator** [8916-34]
Z. Wang, H. Chang, BeiHang Univ. (China); H. Gao, X. Ye, National Institute of Metrology (China)
- 8916 1Y **Digital image correlation method for measuring thermal deformation of composite materials** [8916-47]
L. Jiang, Y. He, D. Wang, K. Liu, Beijing Aerospace Institute for Metrology and Measurement Technology (China); W. Wu, Lunar Exploration and Aerospace Engineering Ctr. (China)
- 8916 1Z **Experimental research on anti-vibration interferometry based on time-frequency-domain analysis** [8916-179]
Y. Hu, Q. Hao, F. Zhang, Y. Tian, Beijing Institute of Technology (China)
- 8916 20 **Fast filtering of surface topography of micro-optics using non-local means** [8916-153]
X. Zhang, H. Zhang, X. He, M. Xu, Fudan Univ. (China)
- 8916 21 **Uncertainty evaluation for a three dimensional rotary measuring system by Markov chain Monte Carlo method** [8916-150]
B. Chen, X. Zhang, H. Zhang, X. He, M. Xu, Fudan Univ. (China)

- 8916 22 **Feasibility study of detection of chatter by using FBG during boring** [8916-182]
P. Y. Zhu, Guangzhou Univ. (China); W. Peng, L. Yuan, Z. J. Hu, Hunan Univ. of Science and Technology (China)

Part 2

- 8916 23 **Radius measurement using a parallel two-step spatial carrier phase-shifting common-path interferometer** [8916-94]
B. Hao, M. Diao, Z. Zhong, M. Shan, Y. Zhang, Harbin Engineering Univ. (China)
- 8916 24 **Image edge enhancement for moving objects with a spiral phase filter** [8916-100]
S. Bao, M. Shan, Z. Zhong, B. Hao, C. An, Harbin Engineering Univ. (China)
- 8916 25 **3D measurement method based on combined temporal encoding structured light** [8916-174]
X. Yu, Y. Wang, S. Yu, H. Cheng, X. Sun, S. Yu, D. Chen, Harbin Univ. of Science and Technology (China)
- 8916 26 **Research of temperature field measurement using a flexible temperature sensor array for robot sensing skin** [8916-149]
Y. Huang, S. Wu, R. Li, Q. Yang, Y. Zhang, C. Liu, Hefei Univ. of Technology (China)
- 8916 27 **Dual AFM probes alignment based on vision guidance** [8916-108]
H. Zhang, Hefei Univ. of Technology (China); S. Gao, Hefei Univ. of Technology (China) and National Institute of Metrology (China); M. Lu, L. Wang, National Institute of Metrology (China)
- 8916 28 **A high-accuracy signal processing algorithm for frequency scanned interferometry** [8916-70]
S. Zhang, Hubei Univ. of Technology (China); L. Yang, X. Wang, Z. Zhai, W. Liu, Hubei Univ. of Technology (China) and Key Lab. of Modern Manufacture Quality Engineering (China)
- 8916 29 **Study on the three-station typical network deployments of workspace measurement and positioning system** [8916-46]
Z. Xiong, Hubei Univ. of Technology (China); J. G. Zhu, B. Xue, S. H. Ye, Tianjin Univ. (China); Y. Xiong, Yunnan Sanhuan Sinochem Chemical Co. (China)
- 8916 2A **Positioning method for a visual guiding system in a laser welding machine** [8916-65]
T. He, Y. Fan, Y. Xie, Q. Wu, Hubei Univ. of Technology (China)
- 8916 2B **Numeric character recognition method based on fractal dimension** [8916-44]
T. He, Y. Xie, J. Chen, L. Cheng, Y. Yuan, Hubei Univ. of Technology (China)
- 8916 2C **Measurement error analysis of the 3D four-wheel aligner** [8916-173]
Q. Zhao, D. Huang, T. Yang, X. Ding, Hunan Univ. of Science and Technology (China)

- 8916 2D **Optimized design of a band-pass filter with low frequency and narrow bandwidth** [8916-171]
B. Tian, G. Fu, X. Liao, Hunan Univ. of Science and Technology (China); H. Cheng, Hunan Univ. of Science and Technology (China) and Institute of Geology and Geophysics (China); G. Li, Hunan Univ. of Science and Technology (China)
- 8916 2E **An apparatus for non-contact measuring profile of precision rotor based on laser triangulation** [8916-170]
X. Yin, T. Yang, Q. Zhao, D. Huang, Hunan Univ. of Science and Technology (China)
- 8916 2F **Mine rescue capsule dynamics modeling and stress analysis** [8916-180]
S. Yang, J. Li, Y. Sun, Hunan Univ. of Science and Technology (China)
- 8916 2G **A new thin-wall beam modal testing method based on single point laser continuous plane scanning vibration measurement** [8916-68]
J. Wu, B. Qin, X. Li, Q. Zhao, Hunan Univ. of Science and Technology (China)
- 8916 2H **Self-adaptive grain recognition of a diamond grinding wheel and its grains assessment** [8916-115]
C. Cui, L. Zhou, Q. Yu, H. Huang, R. Ye, Huaqiao Univ. (China)
- 8916 2I **Correction on the effect of numerical aperture in optical scatterometry** [8916-25]
W. Li, S. Liu, C. Zhang, X. Chen, H. Gu, Huazhong Univ. of Science and Technology (China)
- 8916 2J **Optical character and calibration of 3D vision sensor** [8916-156]
F. Liang, G. Liu, X. He, H. He, J. Shi, H. Zhang, Nanchang Univ. (China) and Nanchang Propersasia Optoelectronic Sci-Tech Dev. Co. (China)
- 8916 2K **Design of PSD based solar direction sensor** [8916-148]
G. Xu, Z. Zhong, B. Wang, R. Guo, Y. Tian, Nanjing Univ. of Aeronautics and Astronautics (China)
- 8916 2L **Smooth sliding mode control with a disturbance observer for a virtual axis parallel mechanism** [8916-102]
D. Jiang, Z. Wang, Z. Wang, X. Zhang, Ningbo Technical College (China)
- 8916 2M **Simulation and design of a fiber Bragg grating flow sensor** [8916-221]
Q. Jiang, F. Gao, Shandong Univ. (China)
- 8916 2N **Design and study of a vibrating string accelerometer based on fiber Bragg grating** [8916-223]
Q. Jiang, M. Yu, L. Sun, Shandong Univ. (China)
- 8916 2O **Placement of the material temperature sensor during measuring the accuracy of CNC machine tools** [8916-178]
D. Zhao, M. Jia, J. Zhang, L. Sun, W. Li, Shandong Institute of Metrology (China)
- 8916 2P **Aberration measurement for progressive addition lens based on Hartmann-Shack Sensor** [8916-89]
L. Zhu, J. Chen, J. Xu, H. Pan, H. Zhang, S. Zhuang, Univ. of Shanghai for Science and Technology (China)

- 8916 2Q **A study on the quality of micro-hole of Ti-6Al-4V by EDM process with on-machine measurement techniques** [8916-48]
J. Li, X. Liu, X. Wei, S. Zhao, Sichuan Univ. (China)
- 8916 2R **A regression-based approach to tolerance values forecasting in micro/meso-scale for micro non-monolithic components** [8916-29]
X. Liu, X. Wei, J. Li, S. Zhao, Sichuan Univ. (China)
- 8916 2S **Soil water evaporation measurement of lysimeter based on fiber Bragg grating sensor** [8916-140]
K. Yan, J. Liu, L. Miao, L. Bai, W. Zhong, Xi'an Univ. of Technology (China)
- 8916 2T **Retrieval of aerosol size distribution based on GCV regularization with optical data of lidar** [8916-21]
H. Zhao, Xi'an Univ. of Technology (China) and Beifang Univ. of Nationalities (China); D. Hua, H. Di, Y. Wang, H. Zhao, Xi'an Univ. of Technology (China); J. Mao, Beifang Univ. of Nationalities (China)
- 8916 2U **Pulse modulation method for LED lidar light source** [8916-36]
W. Zhong, J. Liu, D. Hua, F. Wang, K. Yan, Xi'an Univ. of Technology (China)
- 8916 2V **Design of dual wavelength micro pulse polarization lidar system** [8916-53]
Y. Song, D. Hua, S. Li, Y. Wang, W. Xin, H. Di, Xi'an Univ. of Technology (China)
- 8916 2W **A novel Retinex algorithm based on alternating direction optimization** [8916-37]
X. Fu, Q. Lin, W. Guo, Y. Huang, D. Zeng, X. Ding, Xiamen Univ. (China)
- 8916 2X **Dynamic model of liquid copper temperature based on weighted LS-SVM** [8916-17]
Y. Li, L. Ye, H. Guan, W. Zhong, X. Ma, Zhejiang Univ. (China)
- 8916 2Y **Design of energy-saving control system for LED street lamps** [8916-75]
X. Ding, W. Jin, Zhejiang Univ. (China)
- 8916 2Z **Spectrum measurement for LED-based spectrum-tunable source** [8916-159]
N. Jia, Zhejiang Univ. (China) and Hangzhou Vocational and Technical College (China); Z. Zheng, Y. Yang, H. Wang, Zhejiang Univ. (China)
- 8916 30 **Noise reduction of laser scanning data based on self-estimated angular threshold** [8916-90]
Y. Wu, Zhejiang Univ. (China); W. Wang, K. Lu, Hangzhou Dianzi Univ. (China); Y. Wei, Z. Chen, Zhejiang Univ. (China)
- 8916 31 **Research status and developing trends of grating nanometer measuring technology** [8916-57]
M. Jiang, H. Li, X. Wang, J. Shen, Zhejiang Normal Univ. (China)
- 8916 32 **Roundness measuring instrument for 2-dimensional standards** [8916-131]
W. Wang, National Institute of Metrology (China)
- 8916 33 **Vibration criteria for vibration-sensitive laboratory based on intrinsic microseism** [8916-242]
C. Cai, B. Zhou, J. Li, National Institute of Metrology [China]

- 8916 34 **Development and measurement of single layer thickness standard** [8916-16]
J. Cui, Tianjin Univ. (China) and National Institute of Metrology (China); S. Gao, H. Du, X. Zhu, National Institute of Metrology (China); L. Yan, Zhejiang Sci-Tech Univ. (China)
- 8916 35 **Critical dimensional linewidth calibration using UV microscope and laser interferometry** [8916-161]
Q. Li, S. Gao, W. Li, M. Lu, National Institute of Metrology (China); M. Zhang, Hefei Univ. of Technology (China)
- 8916 36 **Bearing fault diagnosis based on scale-transformation stochastic resonance** [8916-45]
Y. Cui, J. Zhao, T. Guo, Y. Song, China Jiliang Univ. (China)
- 8916 37 **A dedicated on-line detecting system for auto air dryers** [8916-93]
C. Shi, Z. Luo, China Jiliang Univ. (China)
- 8916 38 **Detection technology research on the one-way clutch of automatic brake adjuster** [8916-22]
W. Jiang, Z. Luo, Y. Lu, China Jiliang Univ. (China)
- 8916 39 **Measurement system for characterizing surface friction properties of textile materials** [8916-192]
B. Yao, Y. Yang, Z. Zhang, L. Yan, China Jiliang Univ. (China)
- 8916 3A **Key techniques of ultra-precision aerostatic system** [8916-117]
D. Li, J. Li, T. Cui, J. Hu, Y. Cheng, M. Wang, China Jiliang Univ. (China)
- 8916 3B **ROIC with on-chip sigma-delta AD converter for HgCdTe e-APD FPA** [8916-11]
G. Chen, Shanghai Institute of Technical Physics (China) and Univ. of Chinese Academy of Sciences (China); J. Zhang, Shanghai Institute of Technical Physics (China); P. Wang, J. Zhou, L. Gao, Shanghai Institute of Technical Physics (China) and Univ. of Chinese Academy of Sciences (China); R. Ding, Shanghai Institute of Technical Physics (China)
- 8916 3C **Multi-beam synchronous measurement based on PSD phase detection using frequency-domain multiplexing** [8916-198]
Y. Duan, L. Qin, L. Xuan, F. Xi, J. Mao, Chongqing Univ. (China)
- 8916 3F **A novel design of parallel piezoelectric six-degree-of-freedom accelerometer** [8916-158]
H. Lv, L. Qin, J. Liu, Chongqing Univ. (China)
- 8916 3G **Transformation method from incremental angular displacement sensors to absolute angular displacement sensors** [8916-185]
F. Zheng, Chongqing Univ. of Technology (China)
- 8916 3H **Dynamic high-speed acquisition system design of transmission error with USB based on LabVIEW and FPGA** [8916-35]
Y. Zheng, Y. Chen, Chongqing Univ. of Technology (China)
- 8916 3I **Dynamic self-calibration of time grating sensors based on self-adaptive Kalman filter algorithm** [8916-184]
Z. Chen, Chongqing Univ. of Technology (China)

- 8916 3J **Error analysis and modeling for the time grating length measurement system** [8916-63]
Z. Gao, J. Fen, F. Zheng, Z. Chen, D. Peng, X. Liu, Chongqing Univ. of Technology (China)
- 8916 3K **An improved SURF descriptor based on sector area partitioning** [8916-92]
L. Zeng, Y. Zhai, X. Fang, Academy of Equipment (China)
- 8916 3L **Kinematic modeling and simulation of articulated arm coordinate measuring machines based on MCPC method** [8916-165]
J. Lu, G. Gao, Kunming Univ. of Science and Technology (China)
- 8916 3M **Development of automobile tyre lateral runout measurement sensor** [8916-229]
X. Ma, Ningbo Dahongying College (China); L. Ye, G. Yao, D. Wang, Zhejiang Univ. (China); X. Zhi, Zhejiang Univ. (China) and Anhui Univ. (China)
- 8916 3N **A novel DSSS based ToF measurement method for short baseline and its application in sound velocimeter** [8916-67]
S. Zhao, Y. Wang, C. Qiao, C. Zhou, National Univ. of Defense Technology (China)
- 8916 3O **Transmitting pulse signal design for ultrasonic time of flight measurement in short baseline framework** [8916-15]
S. Zhao, Y. Wang, C. Qiao, C. Zhou, National Univ. of Defense Technology (China)
- 8916 3P **Precise ultrasonic ranging based on pseudo-random sequence modulated continuous signal processing** [8916-142]
C. Qiao, Z. Huang, C. Zhou, National Univ. of Defense Technology (China)
- 8916 3Q **A robust data fusion scheme for integrated navigation systems employing fault detection methodology augmented with fuzzy adaptive filtering** [8916-43]
M. Ushaq, J. Fang, BeiHang Univ. (China)
- 8916 3R **Design of scrap copper separation control system based eddy current sensor** [8916-226]
D. Wang, Zhejiang Univ. (China) and Taiyuan Univ. of Science and Technology (China); X. Ma, L. Ye, G. Yao, Zhejiang Univ. (China); S. Zhang, Zhejiang Univ. (China) and Taiyuan Univ. of Science and Technology (China)
- 8916 3S **The 3D visualization technology research of submarine pipeline based Horde3D GameEngine** [8916-227]
G. Yao, X. Ma, G. Chen, L. Ye, Zhejiang Univ. (China)
- 8916 3T **LED uniform illumination system for DMD-based confocal microscopy** [8916-81]
K. Xiao, W. Hou, Q. Xu, B. Peng, Univ. of Shanghai for Science and Technology (China)
- 8916 3U **Research on direct calibration method of eye-to-hand system of robot** [8916-118]
X. Hu, K. Xie, T. Peng, Hunan Univ. of Science and Technology (China)
- 8916 3V **3D reconstruction of surface based on binocular vision** [8916-189]
X. Hu, T. Peng, K. Xie, Hunan Univ. of Science and Technology (China)
- 8916 3W **A study on the fabrication of main scale of linear encoder using continuous roller imprint method** [8916-98]
S. Fan, Y. Shi, L. Yin, L. Feng, H. Liu, Xi'an Jiaotong Univ. (China)

- 8916 3X **Study on technology of double parallel-joints coordinate measuring machine** [8916-207]
G. Xia, C. Liao, R. Yu, Y. Fu, Nanchang Hangkong Univ. (China)
- 8916 3Y **Three-dimensional shape measurement based on a combination of gray-code and phase-shift light projection** [8916-66]
Z. Wang, Y. Fu, J. Yang, G. Xia, J. Wang, Nanchang Hangkong Univ. (China)
- 8916 3Z **An improving demodulation of interferometric fiber optic sensor technology** [8916-205]
L. Gao, Huainan Union Univ. (China); Y. Li, Z. Chu, Hefei Univ. of Technology (China); M. Wu, China Electronics Technology Group Corp. (China); N. Lin, Hefei Univ. of Technology (China)
- 8916 40 **Digital optimizer based on linear CCD** [8916-116]
Q. Hu, Y. Xu, Guiyang Xintian OETECH Co., Ltd. (China)
- 8916 41 **Research on working clearance optimization for non-contact stress detection with magneto-elastic stress sensor** [8916-213]
Y. Guo, G. Tang W. Wang, Hunan Univ. of Science and Technology (China)
- 8916 42 **Arbitrary and absolute length measurement based on time-of-flight method using femtosecond optical frequency comb** [8916-80]
S. Xing, F. Zhang, Tianjin Univ. (China); S. Cao, National Institute of Metrology (China); X. Qu, Tianjin Univ. (China)
- 8916 43 **The accuracy analysis of the intersection measurement on the moving ships** [8916-24]
M. Wang, Q. Shan, K. Liu, Xi'an Institute of Optics and Precision Mechanics (China)
- 8916 44 **Extending the measuring range of fiber optic displacement sensor with differential evolution optimized extreme learning machine** [8916-110]
X. Wang, M. Ye, M. Jiang, Zhejiang Normal Univ. (China)
- 8916 45 **Image measurement technique on vibration amplitude of ultrasonic horn** [8916-55]
Y. Zhang, Z. Wu, J. Zhu, J. He, G. Liu, Institute of Machinery Manufacturing Technology (China)
- 8916 46 **Study on detection method of inner wall of small-diameter workpiece based on cone reflector** [8916-228]
W. Lu, Shanghai Jiao Tong Univ. (China); Y. Yao, C. Li, Shanghai Institute of Spaceflight Control Technology (China); X. Chen, Shanghai Jiao Tong Univ. (China); L. Shen, Shanghai Institute of Spaceflight Control Technology (China); L. Lei, W. Sun, Shanghai Institute of Measurement and Testing Technology (China)
- 8916 47 **A verification device for the stylus profilometer sensor** [8916-246]
L. Guo, X. Liu, L. Zhou, W. Lu, W. Zhong, Huazhong Univ. of Science and Technology (China); Y. Luo, Wuhan Marine Machinery Plant Co., Ltd. (China)
- 8916 48 **A small angle dynamic measuring device** [8916-247]
J. Wang, X. Liu, W. Lu, L. Chen, Y. Zou, Huazhong Univ. of Science and Technology (China)
- 8916 49 **Comprehensive evaluation of surface topography in running-in wear process** [8916-248]
G. Zhang, X. Liu, W. Lu, Huazhong Univ. of Science and Technology (China)

8916 4B **Research on pre-processing of QR Code** [8916-250]
H. Sun, H. Xia, N. Dong, Hefei Univ. of Technology (China)

Author Index

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- 7 Measurement Signal Analysis and Processing
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 H. X. Deng, Hefei University of Technology (China)
- 8 Quality Engineering and Uncertainty Evaluation
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 M. Chang, Chung Yuan Christian University (Taiwan, China)
- 9 Optical Metrology: Optical Probe and System
 W. H. Zhou, Chinese Academy of Science (China)
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Introduction

With the development of science and technology and the improvement of the requirement in machinery manufacturing, most countries in the world have put lots of human and material resources into the field of mechanical engineering precision measurement research. New methods, new technology and new equipment appear thick and fast. Under this background, we have successfully held five sessions of International Symposium on Precision Mechanical Measurement (ISPMM). The subject and the major topics include length and angular measurement, coordinate measurement technology, micro-nano metrology and MEMS, sensor technology and application, online automatic measurement and control vibration, stress and thermal measurement, opto-electronic measurement and image processing, measurement signal analysis and processing, precision theory and uncertainty evaluation, quality engineering theory and technology and so on. The 6th ISPMM conference was held in Guiyang, August 8-12, and the theme of the conference was "New century, new technology and new development." More than 150 manuscripts were submitted to our conference, and over 200 registered delegates participated in the conference.

Yetai Fei
Shenghua Ye